Notice of References Cited

Application/Control No.

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Examiner

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Applicant(s)/Patent Under
Reexamination
SCHNABEL ET AL.

Art Unit
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,104,277	08-2000	Iniewski et al.	338/311
	В	US-5,293,148	03-1994	Hancock, Peter G.	338/295
	С	US-5,111,068	05-1992	Kusakabe, Hiromi	327/565
	D	US-4,646,056	02-1987	Brokaw, Adrian P.	338/195
	Е	US-4,636,831	01-1987	Ono et al.	257/536
	F	US-4,466,013	08-1984	van de Plassche et al.	257/536
	G	US-4,191,964	03-1980	Kant, Rajni	257/536
	н	US-6,263,740	07-2001	Sridhar et al.	73/754
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	6-5788	01-1994	Japan	Misaki	***************************************
	0	2-7573	01-1990	Japan	Kondo	257/415
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	IBMTDB NN78013096 "Test Site to Dettermine Accurcay. of Automatic Probing Systems" 1/1978, V.20, Iss. 8, pp. 1096-1098
•	٧	
	w	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.